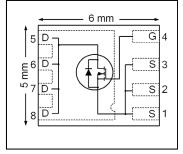




# HEXFET® Power MOSFET

V <sub>DSS</sub>	100	٧
$R_{DS(on)}$ max (@ $V_{GS}$ = 10 $V$ )	5.2	mΩ
Q <sub>g (typical)</sub>	36	nC
R <sub>g (typical)</sub>	1.2	Ω
I <sub>D</sub> (@T <sub>C (Bottom)</sub> = 25°C)	123	Α



results in  $\Rightarrow$ 



# **Applications**

- Primary Switch for High Frequency 48V/60V Telecom DC-DC Power Supplies
- Secondary Side Synchronous Rectifier
- Hot Swap and Active O-Ring

### **Features**

Low $R_{DS(ON)}$ (< 5.2m $\Omega$ )
Low Thermal Resistance to PCB (<0.8°C/W)
100% Rg Tested
Low Profile (<1.05 mm)
Industry-Standard Pinout
Compatible with Existing Surface Mount Techniques
RoHS Compliant, Halogen-Free
MSL1

# Ranafite

Delielits
Lower Conduction Losses
Increased Power Density
Increased Reliability
Increased Power Density
Multi-Vendor Compatibility
Easier Manufacturing
Environmentally Friendlier
Increased Reliability

Base part number	Package Type	Standard Pack		Orderable Part Number
		Form Quantity		
IRFH7185PbF	PQFN 5mm x 6 mm	Tape and Reel	4000	IRFH7185TRPbF

# **Absolute Maximum Ratings**

	Parameter	Max.	Units
$V_{GS}$	Gate-to-Source Voltage	± 20	V
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	19	
I <sub>D</sub> @ T <sub>C(Bottom)</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	123	] ,
I <sub>D</sub> @ T <sub>C(Bottom)</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	78	- A
I <sub>DM</sub>	Pulsed Drain Current ①	260	
P <sub>D</sub> @T <sub>A</sub> = 25°C	Power Dissipation	3.6	W
P <sub>D</sub> @T <sub>C(Bottom)</sub> = 25°C	Power Dissipation	160	
	Linear Derating Factor	0.03	W/°C
T <sub>J</sub>	Operating Junction and	-55 to + 150	°C
T <sub>STG</sub>	Storage Temperature Range		

Notes ① through ⑤ are on page 9



# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		54		mV/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		4.2	5.2	mΩ	$V_{GS} = 10V, I_D = 50A$ ③
$V_{GS(th)}$	Gate Threshold Voltage	2.0		3.6	V	$V_{DS} = V_{GS}, I_{D} = 150 \mu A$
$\Delta V_{GS(th)}$	Gate Threshold Voltage Coefficient		-5.3		mV/°C	
I <sub>DSS</sub>	Drain-to-Source Leakage Current			1.0	μA	$V_{DS} = 80V, V_{GS} = 0V$
$I_{GSS}$	Gate-to-Source Forward Leakage			100	nΛ	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-100	nA	$V_{GS} = -20V$
gfs	Forward Transconductance	117			S	$V_{DS} = 25V, I_{D} = 50A$
$Q_g$	Total Gate Charge		36	54		
Q <sub>gs1</sub>	Pre-Vth Gate-to-Source Charge		7.3			$V_{DS} = 50V$
Q <sub>gs2</sub>	Post-Vth Gate-to-Source Charge		2.7		nC	$V_{GS} = 10V$
$Q_{gd}$	Gate-to-Drain Charge		11			I <sub>D</sub> = 50A
$Q_{godr}$	Gate Charge Overdrive		15			
$Q_{sw}$	Switch Charge (Q <sub>gs2</sub> + Q <sub>gd</sub> )		13.7			
$Q_{oss}$	Output Charge		120		nC	$V_{DS} = 50V$ , $V_{GS} = 0V$
$R_G$	Gate Resistance		1.2		Ω	
$t_{d(on)}$	Turn-On Delay Time		6.5			$V_{DD} = 50V, V_{GS} = 10V$
t <sub>r</sub>	Rise Time		9.9		ns	I <sub>D</sub> = 50A
$t_{d(off)}$	Turn-Off Delay Time		14			$R_G = 1.0\Omega$
t <sub>f</sub>	Fall Time		3.9			
C <sub>iss</sub>	Input Capacitance		2320			V <sub>GS</sub> = 0V
Coss	Output Capacitance		1070		pF	$V_{DS} = 50V$
$C_{rss}$	Reverse Transfer Capacitance		19			f = 1.0MHz

# **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			100		MOSFET symbol
	(Body Diode)		—   —   123		_	showing the
I <sub>SM</sub>	Pulsed Source Current			260	Α	integral reverse
	(Body Diode) ①			260		p-n junction diode.
$V_{SD}$	Diode Forward Voltage		0.8	1.3	V	$T_J = 25^{\circ}C, I_S = 50A, V_{GS} = 0V$ ③
t <sub>rr</sub>	Reverse Recovery Time		63	95	ns	$T_J = 25$ °C, $I_F = 50A$ , $V_{DD} = 50V$
$Q_{rr}$	Reverse Recovery Charge		110	165	nC	di/dt = 100A/µs ③

# **Avalanche Characteristics**

	Parameter	Тур.	Max.	Units
E <sub>AS</sub>	Single Pulse Avalanche Energy ②		360	mJ
I <sub>AR</sub>	Avalanche Current ①		50	Α

# **Thermal Resistance**

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$ (Bottom)	Junction-to-Case 4		0.8	
R <sub>θJC</sub> (Top)	Junction-to-Case 4		19	°C/W
$R_{\theta JA}$	Junction-to-Ambient ©		35	
R <sub>θJA</sub> (<10s)	Junction-to-Ambient ©		23	1



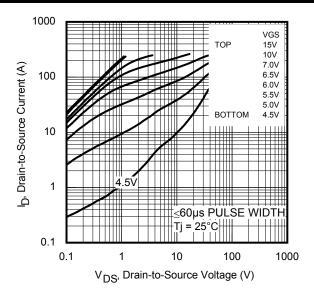


Fig 1. Typical Output Characteristics

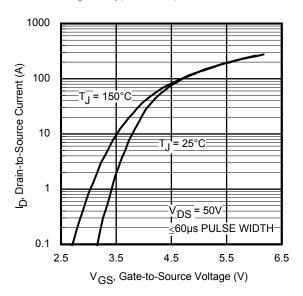


Fig 3. Typical Transfer Characteristics

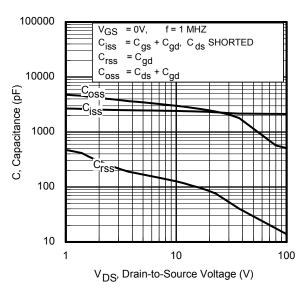


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

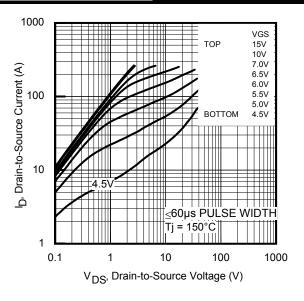


Fig 2. Typical Output Characteristics

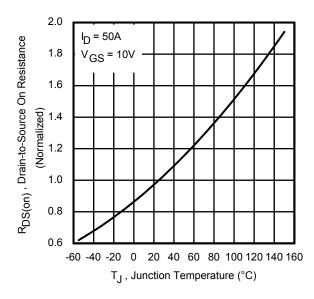


Fig 4. Normalized On-Resistance vs. Temperature

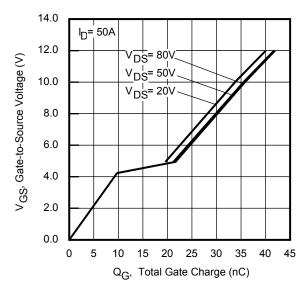


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



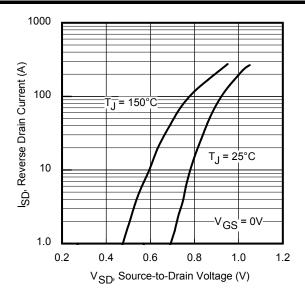


Fig 7. Typical Source-Drain Diode Forward Voltage

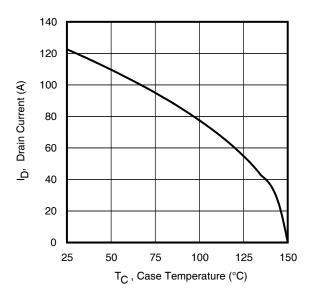


Fig 9. Maximum Drain Current vs. Case Temperature

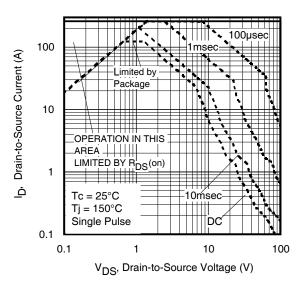


Fig 8. Maximum Safe Operating Area

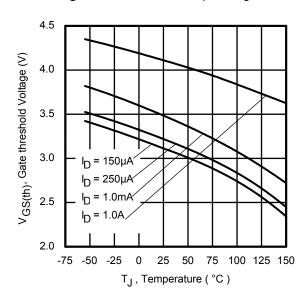


Fig 10. Threshold Voltage vs. Temperature

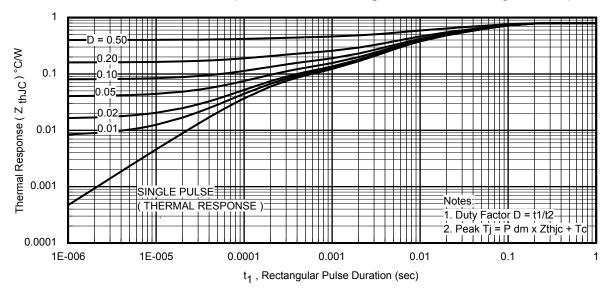


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



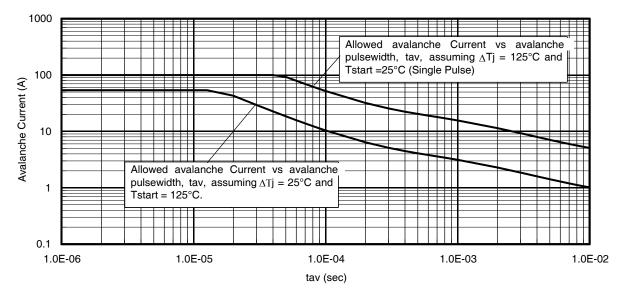


Fig 12. Typical Avalanche Current vs. Pulse Width

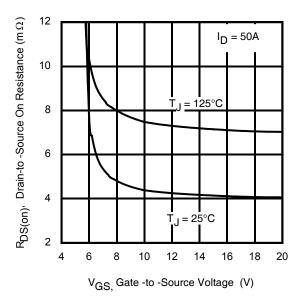


Fig 13. On-Resistance vs. Gate Voltage

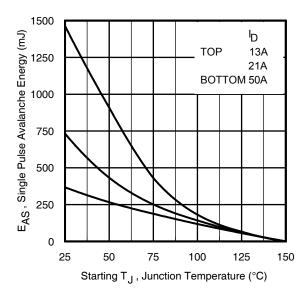


Fig 14. Maximum Avalanche Energy vs. Drain Current



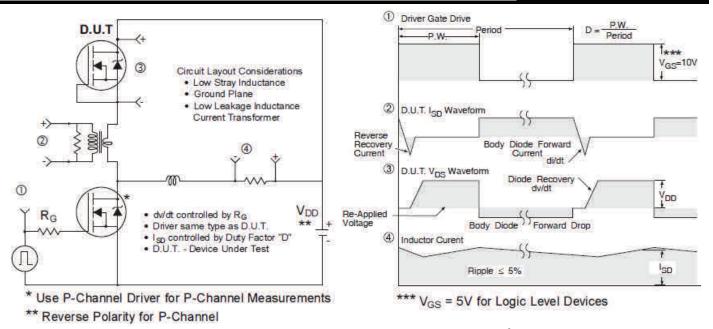


Fig 15. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

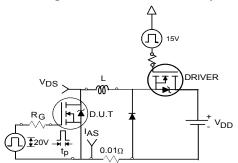


Fig 16a. Unclamped Inductive Test Circuit

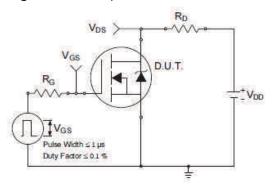


Fig 17a. Switching Time Test Circuit

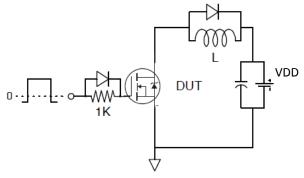


Fig 18. Gate Charge Test Circuit

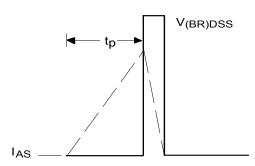


Fig 16b. Unclamped Inductive Waveforms

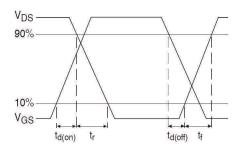


Fig 17b. Switching Time Waveforms

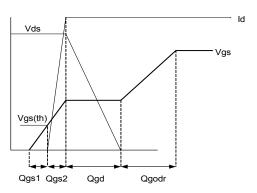
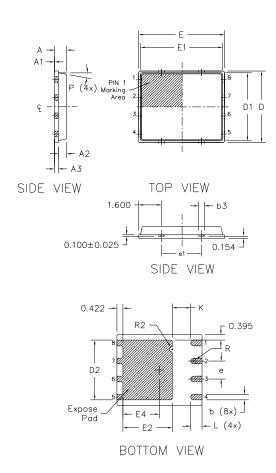


Fig 19. Gate Charge Waveform



# PQFN 5x6 Outline "B" Package Details



DIM	MILLIM	IITERS	IN	ICH	
SYMBOL	MIN	MAX	MIN	MAX	
А	0.800	0.900	0.0315	0.0543	
A1	0.000	0.050	0.0000	0.0020	
А3	0.20	0 REF	0.007	'9 REF	
b	0.350	0.470	0.0138	0.0185	
b1	0.025	0.125	0.0010	0.0049	
b2	0.210	0.410	0.0083	0.0161	
b3	0.150	0.450	0.0059	0.0177	
D	5.00	O BSC	0.1969 BSC		
D1	4.75	O BSC	0.1870 BSC		
D2	4.100	4.300	0.1614	0.1693	
E	6.00	O BSC	0.2362 BSC		
E1	5.75	O BSC	0.2264 BSC		
E2	3.380	3.780	0.1331	0.1488	
е	1.27	70 REF	0.05	OO REF	
e1	2.80	00 REF	0.11	02 REF	
K	1.200	1.420	0.0472	0.0559	
L	0.710	0.900	0.0280	0.0354	
Р	0°	12°	0°	12°	
R	0.200	REF	0.007	9 REF	
R2	0.150	0.200	0.0059	0.0079	

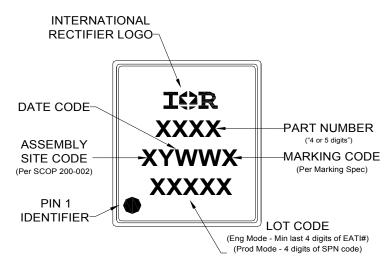
### <u>Note:</u>

- Dimensions and toleranceing confirm to ASME Y14.5M-1994
- Dimension L represents terminal full back from package edge up to 0.1mm is acceptable
- Coplanarity applies to the expose Heat Slug as well as the terminal
- 4. Radius on terminal is Optional

For more information on board mounting, including footprint and stencil recommendation, please refer to application note AN-1136: <a href="http://www.irf.com/technical-info/appnotes/an-1136.pdf">http://www.irf.com/technical-info/appnotes/an-1136.pdf</a>

For more information on package inspection techniques, please refer to application note AN-1154: <a href="http://www.irf.com/technical-info/appnotes/an-1154.pdf">http://www.irf.com/technical-info/appnotes/an-1154.pdf</a>

### **PQFN 5x6 Part Marking**



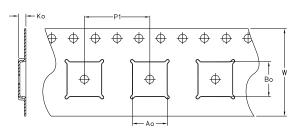
Note: For the most cur-



# PQFN 5x6 Tape and Reel

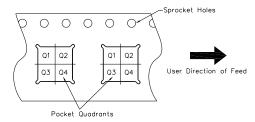
# REEL DIMENSIONS Reel Diameter Reel Width (W1)

### TAPE DIMENSIONS



CODE	DESCRIPTION
Ao	Dimension design to accommodate the component width
Во	Dimension design to accommodate the component lenght
Ko	Dimension design to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Note: All dimension are nominal

	Package Type	Reel Diameter (Inch)	QTY	Reel Width W1 (mm)	Ao (mm)	Bo (mm)	Ko (mm)	P1 (mm)	W (mm)	Pin 1 Quadrant
-	5 X 6 PQFN	13	4000	12.4	6.300	5.300	1.20	8.00	12	Q1

Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>



## Qualifiction Information<sup>†</sup>

Qualification Level	Industrial (per JEDEC JESD47F <sup>††</sup> guidelines)		
Moisture Sensitivity Level	PQFN 5mm x 6mm	MSL1 (per JEDEC J-STD-020D <sup>††)</sup>	
RoHS Compliant	Yes		

<sup>†</sup> Qualification standards can be found at International Rectifier's web site: http://www.irf.com/product-info/reliability/

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25$ °C,  $L = 290\mu H$ ,  $R_G = 50\Omega$ ,  $I_{AS} = 50A$ .
- ③ Pulse width  $\leq 400\mu s$ ; duty cycle  $\leq 2\%$ .
- 4 R<sub> $\theta$ </sub> is measured at T<sub>J</sub> of approximately 90°C.
- © When mounted on 1 inch square PCB (FR-4). Please refer to AN-994 for more details: http://www.irf.com/technical-info/appnotes/an-994.pdf

# **Revision History**

Date		Comments	
	•	Updated the EAS specification on pages 2 & 8.	
3/13/2014	•	Updated the Zth data used on figure 11, page 4.	
	•	Updated figures 8, 11, 12, & 14 on pages 4 & 5.	
6/26/2014	•	<ul> <li>Update package limit current to 123A and Fig.8 &amp; 9 on page 4</li> </ul>	
09/25/2014	•	Corrected Min Gfs from 280S to 117S on page 2	
	•	Updated PQFN 5 x6 Outline "B" Tape and Reel on page 8	
10/20/2014	•	Typo error—Deleted Note # 6 from page 1 and Diode Characteristic Table on page 2	
3/17/2015	•	Updated package outline on pages 7.	



IR WORLD HEADQUARTERS: 101 N. Sepulveda Blvd., El Segundo, California 90245, USA

<sup>††</sup> Applicable version of JEDEC standard at the time of product release.

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